



#### 3MHz, FAST TRANSIENT 2A STEP-DOWN CONVERTER

### **Description**

The PAM2321 is a 2A step-down converter with a typical input voltage of 3.3V and a fixed output voltage of 1.2V or an adjustable output. The 3MHz switching frequency enables the use of small external components. The ultra-small 3mmx3mm footprint and high efficiency make the PAM2321 an ideal choice for portable applications.

The PAM2321 delivers 2A maximum output current while consuming only 55µA no-load quiescent current. Low RDS(ON) integrated MOSFETs and 100% duty cycle operation make the PAM2321 the ideal choice for high output voltage, high current applications which require a low dropout threshold.

The PAM2321 provides excellent transient response and output accuracy across the operating range.

The PAM2321 maintains high efficiency throughout the load range. The PAM2321 automatically optimizes efficiency during light load mode (PSM) and maintains constant frequency and low output ripple during PWM mode.

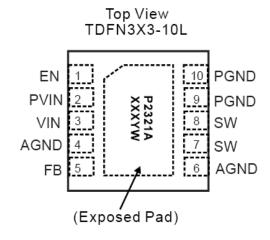
Over-temperature and short circuit protection safeguard the PAM2321 and system components from damage.

The PAM2321 are available in Pb-free, ultrasmall, low profile, TDFN3X3-10 package. The product is rated over a temperature range of -40°C to +85°C.

#### **Features**

- 2A Maximum Output Current
- Tiny 0.47µH Chip Inductor
- **Excellent Transient Response**
- Input Voltage: 2.7V to 5.5V
- Fixed or Adjustable Output Voltage Options:
  - Fixed Output Voltage: 1.2V
  - Adjustable Output Voltage: 1.0V to V<sub>IN</sub>
- High Efficiency with 3MHz Switching Frequency
- 55µA No Load Quiescent Current
- 100% Duty Cycle Low-Dropout Operation
- Internal Soft-Start
- Over-Temperature and Current Limit Protection
- <1µA Shutdown Current
- -40°C to +85°C Temperature Range
- Pb-Free/Halogen Free Package
- RoHS/REACH Compliant

## **Pin Assignments**

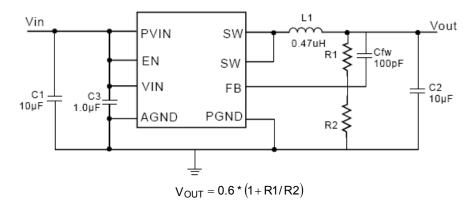


## **Applications**

- Cellular Phone
- **Digital Cameras**
- Hard Disk Drives
- MP3 Players
- PDAs and Handheld Computers
- Portable Media Players
- **USB Devices**
- Wireless Network Cards



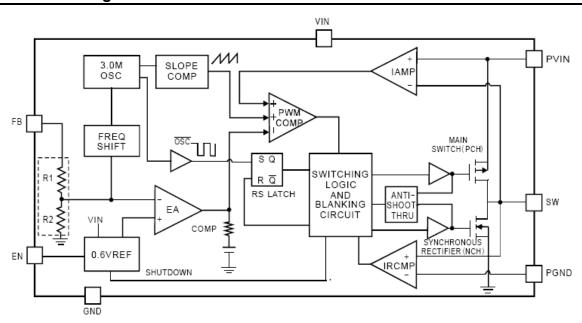
# **Typical Applications Circuit**



## **Pin Descriptions**

Pin Name	Function
PGND	Main power ground return pin. Connect to the output and input capacitor return.
PVIN	Input power supply tied to the source of the high side P-Channel MOSFET.
VIN	Power supply; supplies power for the internal circuitry.
FB	Feedback input pin. This pin is connected directly to the converter output for the 1.2V fixed output version, or connected to an external resistor divider for the adjustable output version.
AGND	Analog ground. This pin is internally connected to the analog ground of the control circuitry.
EN	Enable pin. A logic low disables the converter and it consumes less than 1μA of current. When connected high, it resumes normal operation.
SW	Switching node. Connect the inductor to this pin. It is internally connected to the drain of both high and low side MOSFETs.
EP	Exposed pad of the package provides both electrical contact to the ground and good thermal contact to the PCB. This pad must be soldered to the PCB for proper operation.

## **Functional Block Diagram**







January 2013 © Diodes Incorporated

# **Absolute Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

These are stress ratings only and functional operation is not implied. Exposure to absolute maximum ratings for prolonged time periods may affect device reliability. All voltages are with respect to ground.

Parameter	Rating	Unit
Input Voltage	-0.3 to +6.5	V
EN, FB Pin Voltage	-0.3 to V <sub>IN</sub>	V
SW Pin Voltage	-0.3 to (V <sub>IN</sub> +0.3)	V
Junction Temperature	150	°C
Storage Temperature Range	-65 to +150	°C
Soldering Temperature	300, 5sec	°C

# Recommended Operating Conditions (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Parameter	Rating	Unit
Supply Voltage	2.5 to 5.5	V
Operation Temperature Range	-40 to +85	°C
Junction Temperature Range	-40 to +125	]

### **Thermal Information**

Parameter	Symbol	Package	Max	Unit	
Thermal Resistance (Junction to Case)	$\theta_{JC}$	TDFN3x3-10	8.5	8.5	
Thermal Resistance (Junction to Ambient)	$\theta_{JA}$	TDFN3x3-10	60 °C/W		
Internal Power Dissipation	P <sub>D</sub>	TDFN3x3-10	1.66	W	

PAM2321 3 of 11 Document number: DSxxxxx Rev. 2 - 1





**PAM2321** 

### **Electrical Characteristics**

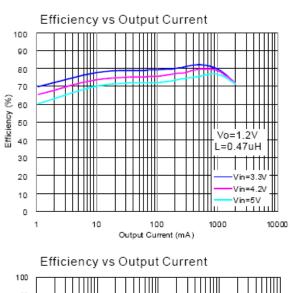
 $(@T_{A} = +25^{\circ}C, \ V_{IN} = 3.3V, \ V_{OUT} = 1.2V, \ C_{IN} = 10\mu F, \ C_{O} = 10\mu F, \ L = 0.47\mu H, \ unless \ otherwise \ specified.)$ 

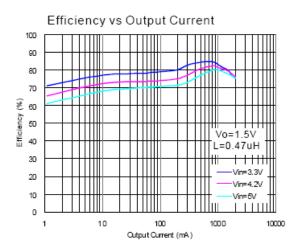
Parameter	Symbol	Test Conditions		Min	Тур	Max	Units
Input Voltage Range	V <sub>IN</sub>			2.7	3.3	5.5	V
	V <sub>UVLO</sub>	V <sub>IN</sub> Rising			2.6	2.7	V
UVLO Threshold		Hysteresis			250		mV
		V <sub>IN</sub> Falling		2			V
Output Voltage Range	V <sub>OUT</sub>			1	1.2	V <sub>IN</sub>	V
Output Voltage Accuracy	V <sub>OUT</sub>	I <sub>O</sub> = 0mA		-3.0		+3.0	%
Regulated Feedback Voltage	$V_{FB}$	No Load		0.588	0.600	0.612	V
PMOS Current Limit	I <sub>LIM</sub>				3.0		Α
Output Voltage Line Regulation	LNR	V <sub>IN</sub> = 3.3V to 4V			0.3		%/V
Output Voltage Load Regulation	LDR	I <sub>O</sub> = 1mA to 2A			1		%/A
Quiescent Current	IQ	No Load			55	90	μA
Shutdown Current	I <sub>SD</sub>	V <sub>EN</sub> = 0V				1	μA
Oscillator Frequency	fosc				3		MHz
Drain-Source On-State Resisitance	R <sub>DS(ON)</sub>	I <sub>DS</sub> = 100mA	P MOSFET		130		mΩ
Diain-Source On-State Resistance			N MOSFET		90		mΩ
SW Leakage Current	I <sub>LSW</sub>					1	μA
Start-Up Time	ts	V <sub>IN</sub> = 3.3V, V <sub>O</sub> = 1.2V			200		μs
PSM Threshold	I <sub>TH</sub>				200		mA
EN Threshold High	V <sub>EH</sub>			1.4			V
EN Threshold Low	V <sub>EL</sub>					0.4	V
EN Leakage Current	I <sub>EN</sub>				±0.01		μA
Over Temperature Protection	OTP				150		°C
OTP Hysteresis	OTH				30		°C

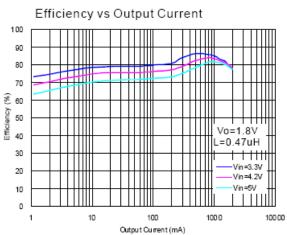


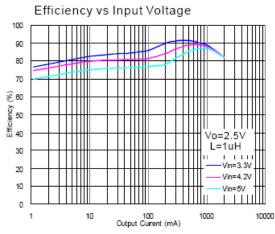


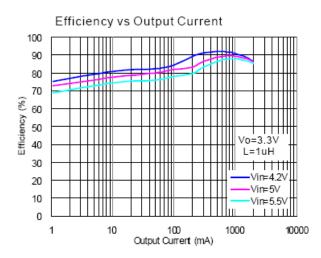
## Typical Performance Characteristics (@T<sub>A</sub> = +25°C, C<sub>IN</sub> = 10μF, C<sub>O</sub> = 10μF, L = 0.47μH unless otherwise specified.)

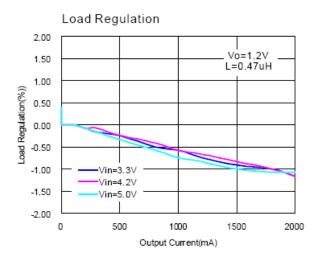






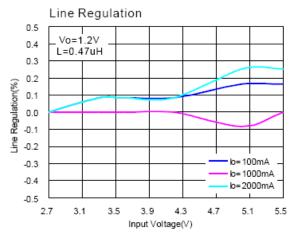


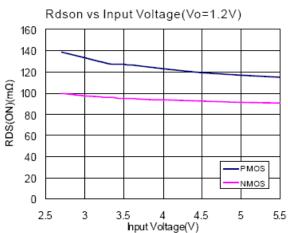


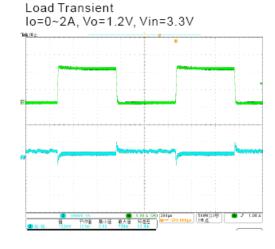


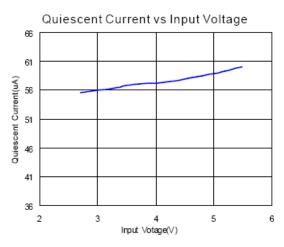


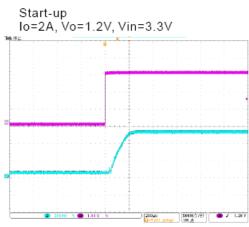
# Typical Performance Characteristics (cont.) (@ $T_A$ = +25°C, $C_{IN}$ = 10 $\mu$ F, $C_O$ = 10 $\mu$ F, L = 0.47 $\mu$ H unless otherwise specified.)

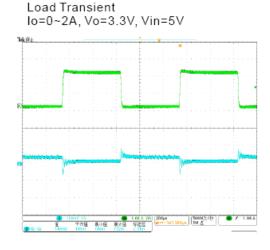














January 2013

© Diodes Incorporated

### **Application Information**

The basic PAM2321 application circuit is shown in Page 2. External component selection is determined by the load requirement, selecting L first and then CIN and COUT.

#### **Inductor Selection**

For most applications, the value of the inductor will fall in the range of 1µH to 4.7µH. Its value is chosen based on the desired ripple current and efficiency. Large value inductors lower ripple current and small value inductors result in higher ripple currents. Higher V<sub>IN</sub> or V<sub>OUT</sub> also increases the ripple current as shown in equation 3.0. A reasonable starting point for setting ripple current is ΔI<sub>L</sub> = 800mA (40% of 2A).

$$\Delta I_{L} = \frac{1}{(f)(L)} V_{OUT} \left( 1 - \frac{V_{OUT}}{V_{IN}} \right)$$
 Equation (1)

The DC current rating of the inductor should be at least equal to the maximum load current plus half the ripple current to prevent core saturation. Thus, a 2.8A rated inductor should be enough for most applications (2A + 800mA). For better efficiency, choose a low DC-resistance inductor.

#### CIN and COUT Selection

In continuous mode, the source current of the top MOSFET is a square wave of duty cycle V<sub>OUT</sub>/V<sub>IN</sub>. To prevent large voltage transients, a low ESR input capacitor sized for the maximum RMS current must be used. The maximum RMS capacitor current is given by:

$$C_{IN}$$
 required  $I_{RMS} \cong I_{OMAX} \frac{\left[V_{OUT} \left(V_{IN} - V_{OUT}\right)\right]^{1/2}}{V_{IN}}$ 

This formula has a maximum at V<sub>IN</sub> = 2V<sub>OUT</sub>, where I<sub>RMS</sub> = I<sub>OUT</sub> /2. This simple worst-case condition is commonly used for design because even significant deviations do not offer much relief. Note that the capacitor manufacturer's ripple current ratings are often based on 2000 hours of life. This makes it advisable to further derate the capacitor, or choose a capacitor rated at a higher temperature than required. Consult the manufacturer if there is any question.

The selection of C<sub>OUT</sub> is driven by the required effective series resistance (ESR).

Typically, once the ESR requirement for Cout has been met, the RMS current rating generally far exceeds the IRIPPLE (P-P) requirement. The output ripple  $\Delta V_{OUT}$  is determined by:

$$\Delta V_{OUT} \approx \Delta I_{L} \left( ESR + \frac{1}{8fC_{OUT}} \right)$$

Where f = operating frequency,  $C_{OUT}$  = output capacitance and  $\Delta I_L$  = ripple current in the inductor. For a fixed output voltage, the output ripple is highest at maximum input voltage since ΔI<sub>L</sub> increases with input voltage.

### **Using Ceramic Input and Output Capacitors**

Higher values, lower cost ceramic capacitors are now becoming available in smaller case sizes. Their high ripple current, high voltage rating and low ESR make them ideal for switching regulator applications. Using ceramic capacitors can achieve very low output ripple and small circuit size.

When choosing the input and output ceramic capacitors, choose the X5R or X7R dielectric formul ations. These dielectrics have the best temperature and voltage characteristics of all the ceramics for a given value and size.

#### **Thermal Consideration**

Thermal protection limits power dissipation in the PAM2321. When the junction temperature exceeds +150°C, the OTP (Over Temperature Protection) starts the thermal shutdown and turns the pass transistor off. The pass transistor resumes operation after the junction temperature drops below +120°C.

For continuous operation, the junction temperature should be maintained below +125°C. The power dissipation is defined as:

$$P_{D} = I_{O}^{2} \frac{V_{O} R_{DS(ON)H} + (V_{IN} - V_{O}) R_{DS(ON)L}}{V_{IN}} + (t_{SW} F_{S} I_{O} + I_{Q}) V_{IN}$$

IQ is the step-down converter quiescent current. The term tsw is used to estimate the full load step-down converter switching losses.

7 of 11 PAM2321 Document number: DSxxxxx Rev. 2 - 1



### **Application Information (cont.)**

For the condition where the step-down converter is in dropout at 100% duty cycle, the total device dissipation reduces to:

$$P_D = I_O^2 R_{DS(ON)H} + I_O V_{IN}$$

Since R<sub>DS(ON)</sub>, quiescent current, and switching losses all vary with input voltage, the total losses should be investigated over the complete input voltage range. The maximum power dissipation depends on the thermal resistance of IC package, PCB layout, the rate of surrounding airflow and temperature difference between junction and ambient. The maximum power dissipation can be calculated by the following formula:

$$P_D = \frac{T_{J(MAX)} - T_A}{\theta_{JA}}$$

Where  $T_{J(MAX)}$  is the maximum allowable junction temperature +125°C.  $T_A$  is the ambient temperature and  $\theta_{JA}$  is the thermal resistance from the junction to the ambient. Based on the standard JEDEC for a two layers thermal test board, the thermal resistance θ<sub>JA</sub> of TDFN3x3 package is 60°C/W. The maximum power dissipation at T<sub>A</sub> = +25°C can be calculated by following formula:

$$P_D = (125^{\circ}C - 25^{\circ}C) / 60^{\circ}C/W = 1.66W$$

#### **Setting the Output Voltage**

The internal reference is 0.6V (Typical). The output voltage is calculated as below:

The output voltage is given by Table 1.

$$V_O = 0.6x \left(1 + \frac{R1}{R2}\right)$$

Table 1: Resistor selection for output voltage setting.

Vo	R1	R2
1.2V	100k	100k
1.5V	150k	100k
1.8V	200k	100k
2.5V	380k	120k
3.3V	540k	120k

#### Pulse Skipping Mode (PSM) Description

When load current decreases, the peak switch current in Power-PMOS will be lower than skip current threshold and the device will enter into Pulse Skipping Mode.

In this mode, the device has two states, working state and idle state. First, the device enters into working state control led by internal error amplifier. When the feedback voltage gets higher than internal reference voltage, the device will enter into low Iq idle state with most of internal blocks disabled. The output voltage will be reduced by loading or leakage current. When the feedback voltage gets lower than the internal reference voltage, the convertor will start a working state again.

### 100% Duty Cycle Operation

As the input voltage approaches the output voltage, the converter turns the P-Channel transistor continuously on. In this mode the output voltage is equal to the input voltage minus the voltage drop across the P-Channel transistor:

$$V_{OUT} = V_{IN} - I_{LOAD} (R_{DSON} + R_L)$$

where R<sub>DS(ON)</sub> = P-Channel switch ON resistance, I<sub>LOAD</sub> = Output Current, R<sub>L</sub> = Inductor DC Resistance

#### **UVLO and Soft-Start**

The reference and the circuit remain reset until the V<sub>IN</sub> crosses its UVLO threshold. The PAM2321 has an internal soft-start circuit that limits the in-rush current during start-up. This prevents possible voltage drops of the input voltage and eliminates the output voltage overshoot.

8 of 11 PAM2321 Document number: DSxxxxx Rev. 2 - 1





### **Application Information (cont.)**

#### **Short Circuit Protection**

When the converter output is shorted or the device is overloaded, each high-side MOSFET current-limit event (3A typ) turns off the high-side MOSFET and turns on the low-side MOSFET. An internal counter is used to count the each current-limit event. The counter is reset after consecutive high-side MOSFETs turn on without reaching current limit. If the current-limit condition persists, the counter fills up. The control logic then stops both high-side and lowside MOSFETs and waits for a hiccup period, before attemping a new soft-start sequence. The counter bits is decided by V<sub>FB</sub> voltage. If ≤V<sub>FB</sub> 0 2, the counter is 3-bit counter; if V<sub>FB</sub> >0.2 the counter is 6-bit counter. The typical hicuup made duty cycle is 1.7%. The hiccup mode is disable during soft-start time.

#### **Thermal Shutdown**

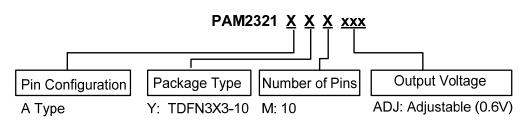
When the die temperature exceeds +150°C, a reset occurs and the reset remains until the temperature decrease to +120°C, at which time the circuit can be restarted.

#### **PCB Layout Check List**

When laying out the printed circuit board, the following checklist should be used to ensure proper operation of the PAM2321. Check the following in your layout:

- 1. The input capacitor should be close to IC as close as possible.
- 2. Must put a small decoupling capacitor between VIN PIN and AGND Pin.
- 3. Minimize the switching loop area to avoid excessive switching noise.
- 4. AGND and PGND should connect at input capacitor GND.
- 5. For the good thermal dissipation, PAM2321 has a heat dissipate pad in the bottom side, it should be soldered to PCB surface. For the copper area can't be large in the component side, so we can use mu Itiple vias connect to other side of the PCB.

## Ordering Information

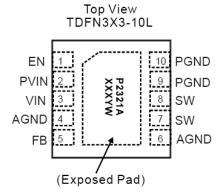


Part Number	Output Voltage	Part Type	Standard Package
PAM2321AYMADJ	P2321A XXXYW	T-DFN3x3-10	3000 Units/Tape & Reel

9 of 11 PAM2321 January 2013 Document number: DSxxxxx Rev. 2 - 1 © Diodes Incorporated



# **Marking Information**

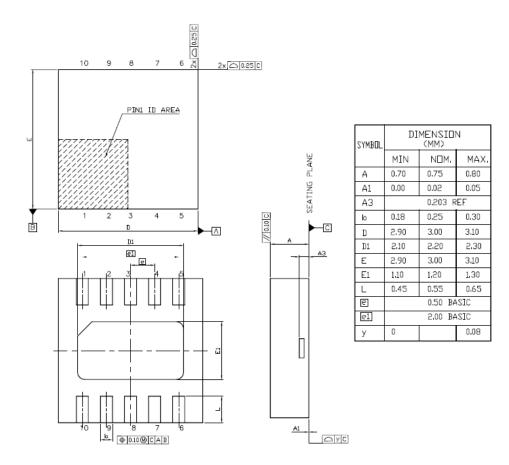


A/B : Pin Configuration X : Internal Code Y : Year

W : Week

# Package Outline Dimensions (All dimensions in mm.)

#### TDFN3x3-10







#### **IMPORTANT NOTICE**

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application. Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

#### **LIFE SUPPORT**

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
  - 1. are intended to implant into the body, or
  - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2013. Diodes Incorporated

www.diodes.com

11 of 11 PAM2321 January 2013 © Diodes Incorporated Document number: DSxxxxx Rev. 2 - 1

单击下面可查看定价,库存,交付和生命周期等信息

>>Diodes Incorporated(达尔科技)